


<b>Search Notes</b>  	<b>Application/Control No.</b>  10538549	<b>Applicant(s)/Patent Under Reexamination</b>  KANG ET AL.
	<b>Examiner</b>  Takele, Meseker	<b>Art Unit</b>  2175

### SEARCHED

Class	Subclass	Date	Examiner
715	816, 715, 711, 827, 864, 811	8/2/2008	MT
455	550.1	8/2/2008	MT
345	157, 161, 169	8/2/2008	MT

### SEARCH NOTES

Search Notes	Date	Examiner
East (US -PGPUB, USPAT, IBM_TDB, USOCR, FPRS, EPO, JPO, DERWENT)	8/2/2008	MT
Consult wit Primary Sy Luu	07/02/2007	MT
Consult with Lance Sealey (Search strategy expert)	06/28/2007	MT
NPL search	8/2/2008	MT
Inventor search	8/2/2008	MT
Consult with William Bashore (spe)	7/25/2008	MT

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
715	816, 715, 711, 827, 864, 811	8/2/2008	MT